## Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination | KOMIYA ET AL. | Examiner | Art Unit | Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2001/0053260	12-2001	Takizawa et al.	385/14
	В	US-6,078,707	06-2000	Yamamoto et al.	385/14
	O	US-2002/0031307	03-2002	Kimura, Naoki	385/49
	D	US-6,477,285	11-2002	Shanley, Charles W.	385/14
	E	US-			
	F	US-			
	G	US-		·	
	Н	US-			
	1	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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	S					
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## **NON-PATENT DOCUMENTS**

NON-FAILNI DOCUMENTS					
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U				
	V				
	8				
	x				

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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